

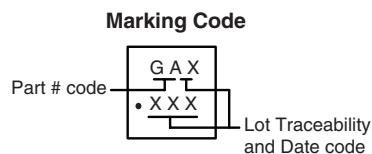
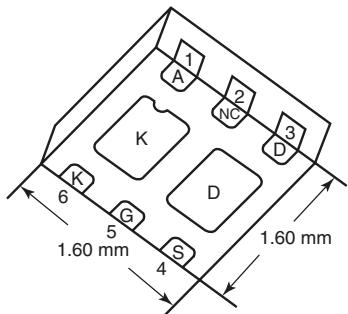


## N-Channel 20-V (D-S) MOSFET with Trench Schottky Diode

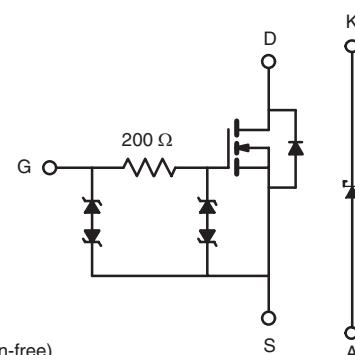
PRODUCT SUMMARY			
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> ( $\Omega$ )	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)
20	0.225 at V <sub>GS</sub> = 4.5 V	1.5	1.1 nC
	0.270 at V <sub>GS</sub> = 2.5 V	1.5	
	0.345 at V <sub>GS</sub> = 1.8 V	1.5	
	0.960 at V <sub>GS</sub> = 1.5 V	0.5	

SCHOTTKY PRODUCT SUMMARY		
V <sub>KA</sub> (V)	V <sub>f</sub> (V) Diode Forward Voltage	I <sub>F</sub> (A) <sup>a</sup>
30	0.29 at 10 mA	0.4

PowerPAK SC75-6L-Dual



Ordering Information: SiB800EDK-T1-GE3 (Lead (Pb)-free and Halogen-free)



ABSOLUTE MAXIMUM RATINGS T <sub>A</sub> = 25 °C, unless otherwise noted			
Parameter	Symbol	Limit	Unit
Drain-Source Voltage (MOSFET)	V <sub>DS</sub>	20	V
Reverse Voltage (Schottky)	V <sub>KA</sub>	30	
Gate-Source Voltage (MOSFET)	V <sub>GS</sub>	± 6	
Continuous Drain Current (T <sub>J</sub> = 150 °C) (MOSFET)	I <sub>D</sub>	1.5 <sup>a</sup>	
		1.5 <sup>a</sup>	
		1.5 <sup>a, b, c</sup>	
		1.3 <sup>b, c</sup>	
Pulsed Drain Current (MOSFET)	I <sub>DM</sub>	4	A
Continuous Source-Drain Diode Current (MOSFET Diode Conduction)	I <sub>S</sub>	1.5 <sup>a</sup>	
		0.9 <sup>b, c</sup>	
Average Forward Current (Schottky)	I <sub>F</sub>	0.4 <sup>b</sup>	
Pulsed Forward Current (Schottky)	I <sub>FM</sub>	0.8	W
Maximum Power Dissipation (MOSFET)	P <sub>D</sub>	3.1	
		2	
		1.1 <sup>b, c</sup>	
		0.7 <sup>b, c</sup>	
Maximum Power Dissipation (Schottky)		3.1	
		2	
		1.1 <sup>b, c</sup>	
		0.7 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>		260	

**THERMAL RESISTANCE RATINGS**

Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient (MOSFET) <sup>b, f</sup>	$t \leq 5 \text{ s}$	$R_{\text{thJA}}$	90	115	$^{\circ}\text{C/W}$
Maximum Junction-to-Case (Drain) (MOSFET)	Steady State	$R_{\text{thJC}}$	32	40	
Maximum Junction-to-Ambient (Schottky) <sup>b, f</sup>	$t \leq 5 \text{ s}$	$R_{\text{thJA}}$	90	115	
Maximum Junction-to-Case (Drain) (Schottky)	Steady State	$R_{\text{thJC}}$	32	40	

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c.  $t = 5 \text{ s}$ .
- d. See Solder Profile ([www.vishay.com/ppg?73257](http://www.vishay.com/ppg?73257)). The PowerPAK SC-75 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 125  $^{\circ}\text{C/W}$ .

**SPECIFICATIONS**  $T_J = 25 \text{ } ^{\circ}\text{C}$ , unless otherwise noted

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20			V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250 \mu\text{A}$		21		$\text{mV}/^{\circ}\text{C}$
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$			- 2.3		
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	0.4		1.0	V
Gate-Source Leakage	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 3 \text{ V}$			$\pm 1$	$\mu\text{A}$
		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 6 \text{ V}$			$\pm 1$	mA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1	$\mu\text{A}$
		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 \text{ } ^{\circ}\text{C}$			10	
On-State Drain Current <sup>a</sup>	$I_{D(\text{on})}$	$V_{DS} \geq 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	4			A
Drain-Source On-State Resistance <sup>a</sup>	$R_{DS(\text{on})}$	$V_{GS} = 4.5 \text{ V}, I_D = 1.6 \text{ A}$		0.183	0.225	$\Omega$
		$V_{GS} = 2.5 \text{ V}, I_D = 1.5 \text{ A}$		0.220	0.270	
		$V_{GS} = 1.8 \text{ V}, I_D = 1.3 \text{ A}$		0.275	0.345	
		$V_{GS} = 1.5 \text{ V}, I_D = 0.3 \text{ A}$		0.320	0.960	
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = 10 \text{ V}, I_D = 1.6 \text{ A}$		3.5		S
<b>Dynamic<sup>b</sup></b>						
Total Gate Charge	$Q_g$	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1.7 \text{ A}$		1.1	1.7	$\text{nC}$
Gate-Source Charge	$Q_{gs}$			0.2		
Gate-Drain Charge	$Q_{gd}$			0.1		
Gate Resistance	$R_g$	$f = 1 \text{ MHz}$		200		$\Omega$
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = 10 \text{ V}, R_L = 7.7 \Omega$ $I_D \cong 1.3 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		20	30	$\text{ns}$
Rise Time	$t_r$			12	20	
Turn-Off DelayTime	$t_{d(\text{off})}$			70	105	
Fall Time	$t_f$			20	30	
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25 \text{ } ^{\circ}\text{C}$			1.5	$\text{A}$
Pulse Diode Forward Current	$I_{SM}$				4	
Body Diode Voltage	$V_{SD}$	$I_S = 1.3 \text{ A}, V_{GS} = 0 \text{ V}$		0.9	1.2	V

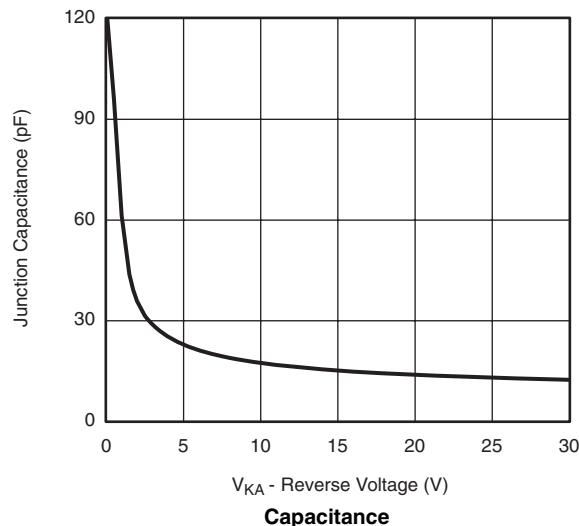
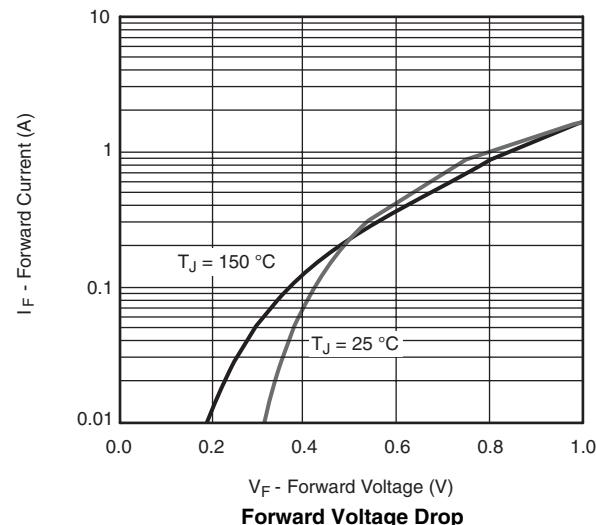
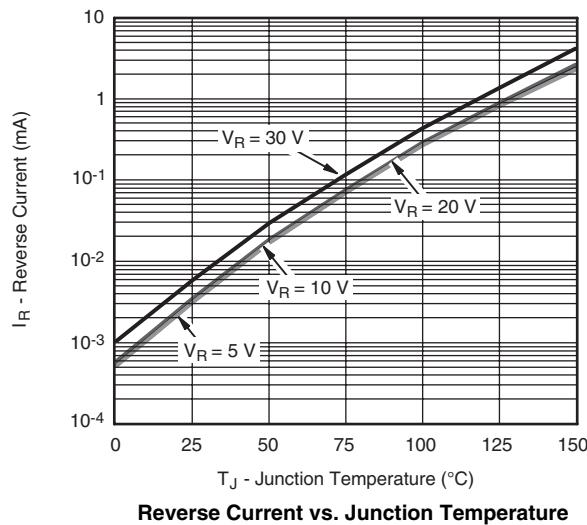
Notes:

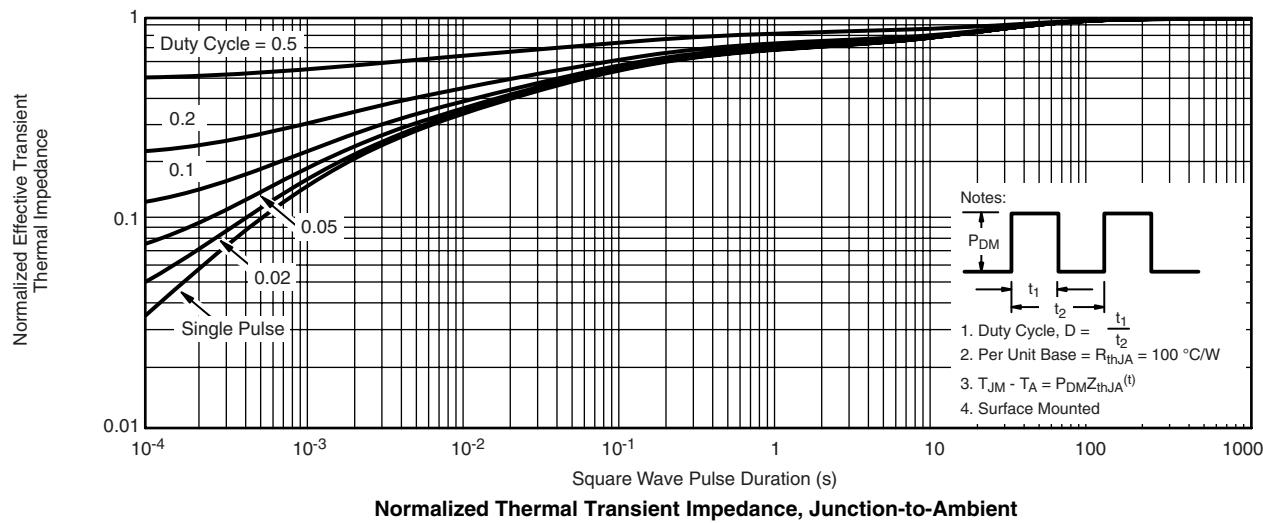
- a. Pulse test; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2 \%$ .
- b. Guaranteed by design, not subject to production testing.

**SCHOTTKY SPECIFICATIONS**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

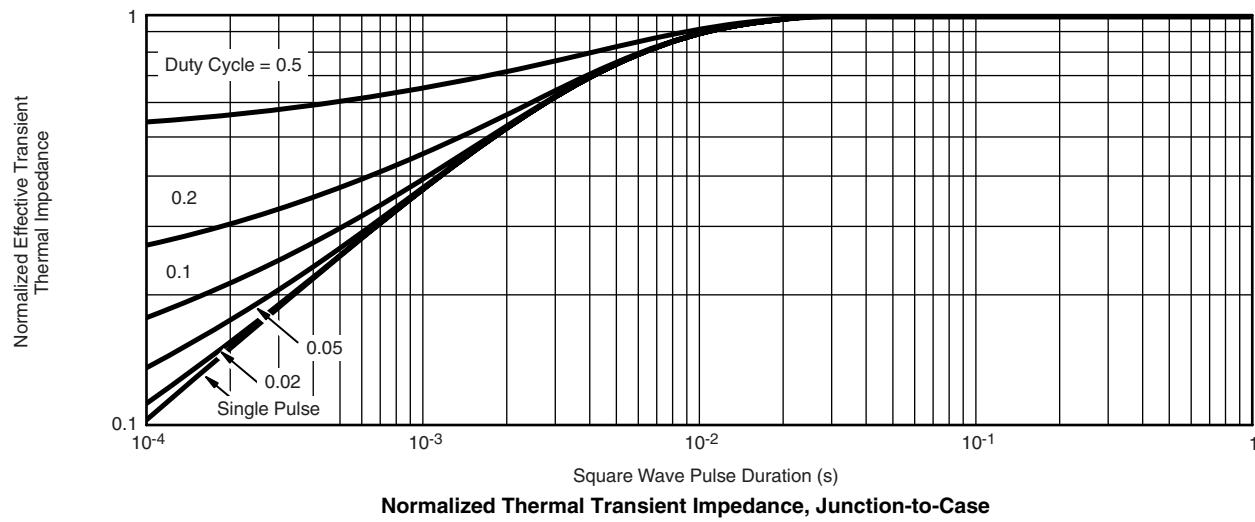
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Forward Voltage Drop	$V_F$	$I_F = 10 \text{ mA}$		0.23	0.29	V
		$I_F = 10 \text{ mA}, T_J = 125^\circ\text{C}$		0.11	0.14	
		$I_F = 0.1 \text{ A}$		0.32	0.38	
Maximum Reverse Leakage Current	$I_{rm}$	$V_r = 20 \text{ V}$		0.005	0.050	mA
		$V_r = 20 \text{ V}, T_J = 85^\circ\text{C}$		0.150	1.5	
Junction Capacitance	$C_T$	$V_r = 15 \text{ V}$		16		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

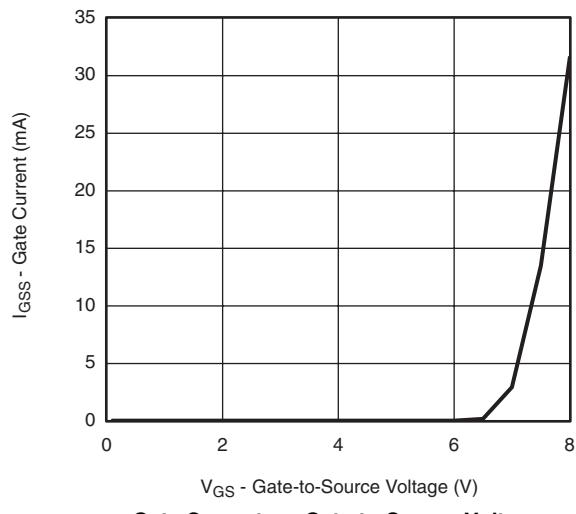
**SCHOTTKY TYPICAL CHARACTERISTICS**  $T_A = 25^\circ\text{C}$ , unless otherwise noted

**SCHOTTKY TYPICAL CHARACTERISTICS**  $T_A = 25^\circ\text{C}$ , unless otherwise noted

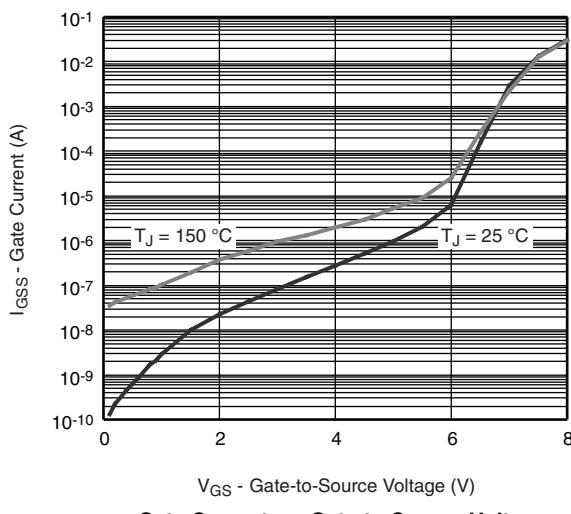
Normalized Thermal Transient Impedance, Junction-to-Ambient



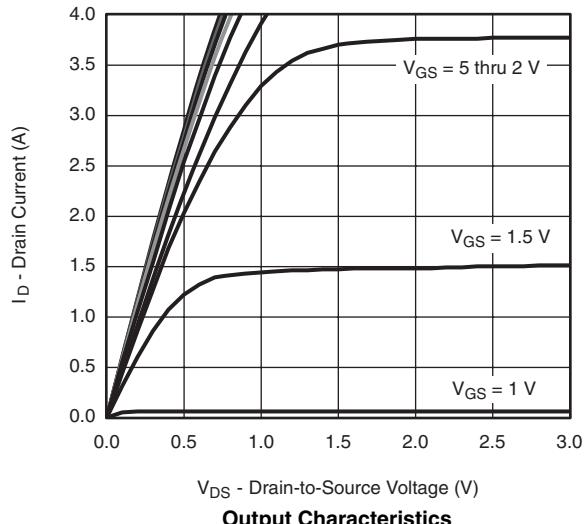
Normalized Thermal Transient Impedance, Junction-to-Case

**MOSFET TYPICAL CHARACTERISTICS**  $T_A = 25\text{ }^{\circ}\text{C}$ , unless otherwise noted

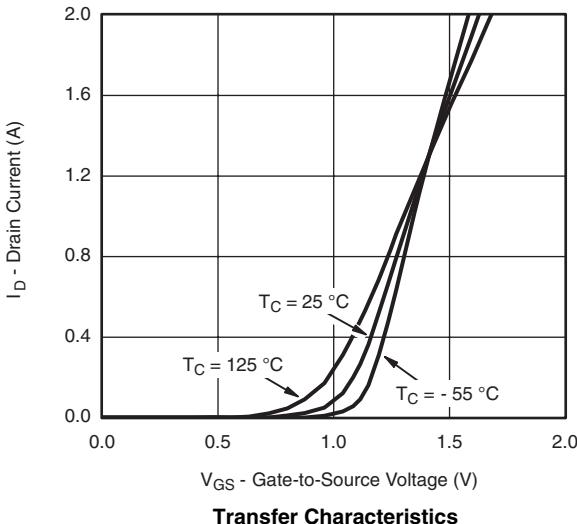
Gate Current vs. Gate-to-Source Voltage



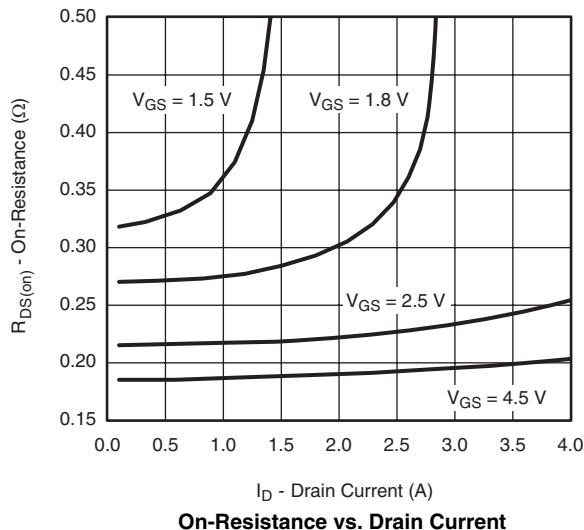
Gate Current vs. Gate-to-Source Voltage



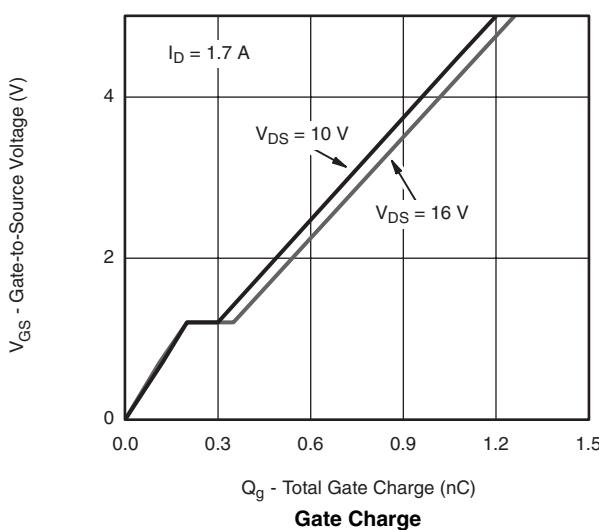
Output Characteristics



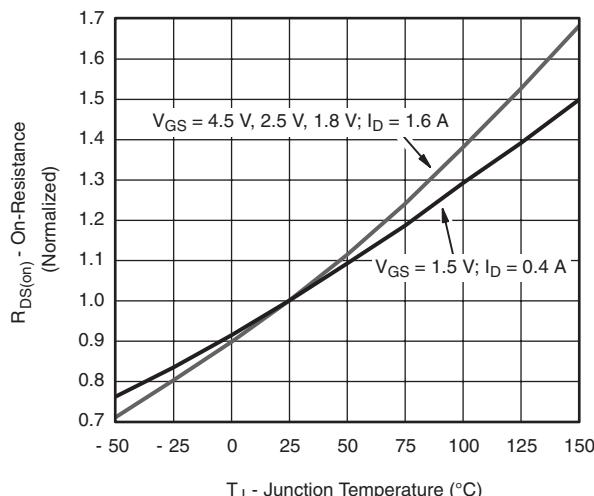
Transfer Characteristics



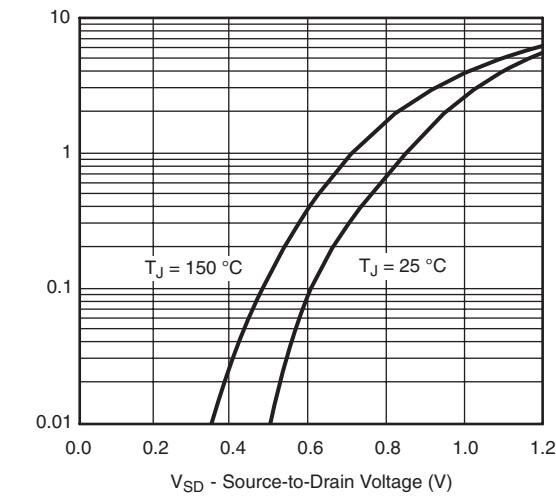
On-Resistance vs. Drain Current



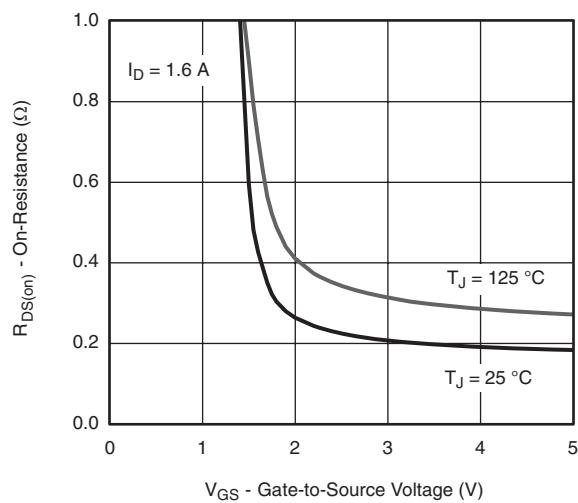
Gate Charge

**MOSFET TYPICAL CHARACTERISTICS**  $T_A = 25^\circ\text{C}$ , unless otherwise noted

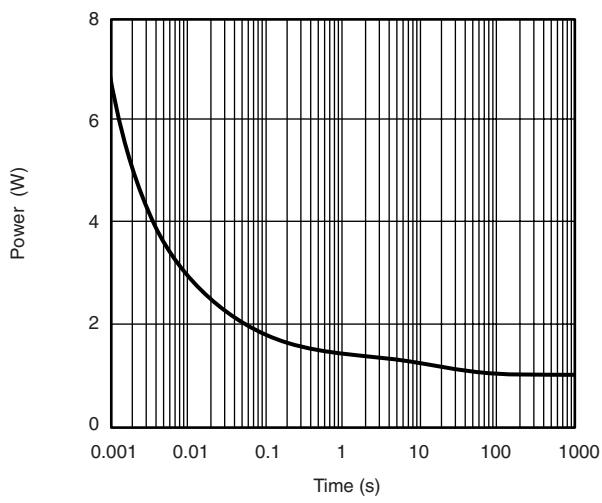
Normalized On-Resistance vs. Junction Temperature



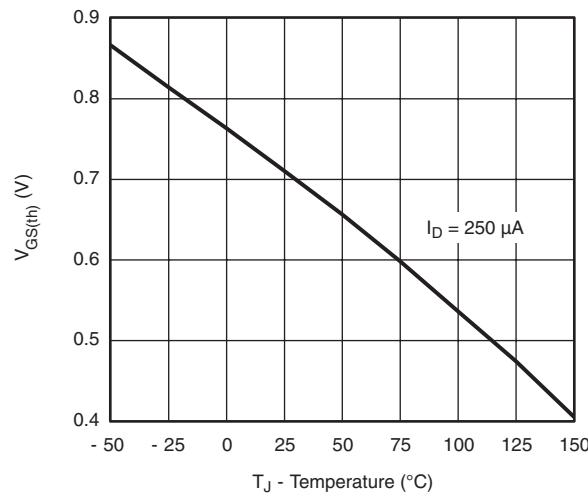
Source-Drain Diode Forward Voltage



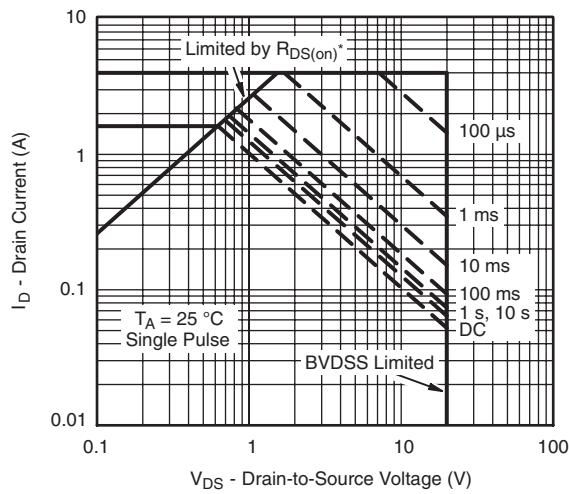
On-Resistance vs. Gate-to-Source Voltage



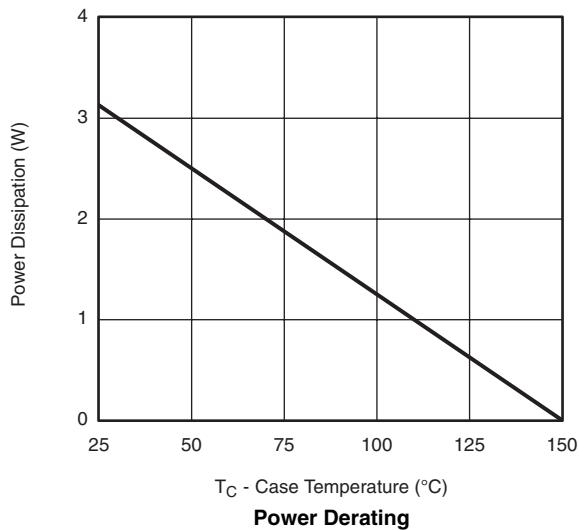
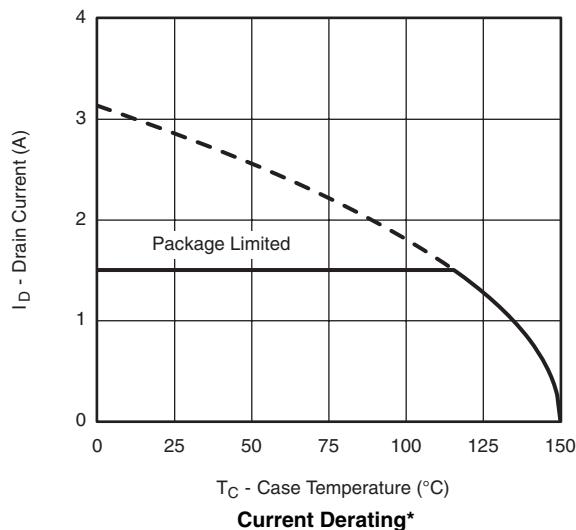
Single Pulse Power, Junction-to-Ambient



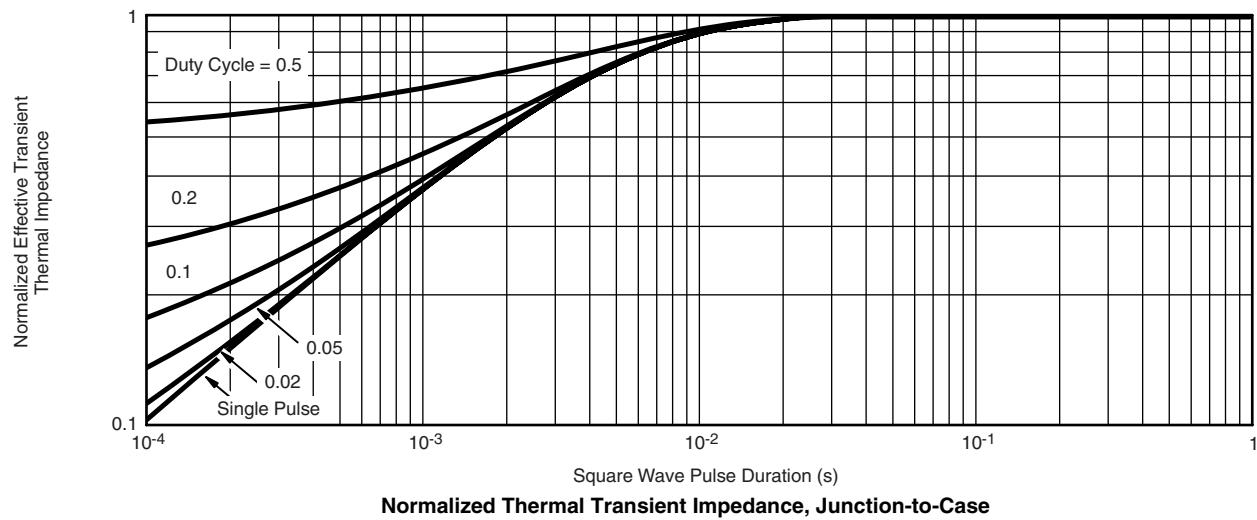
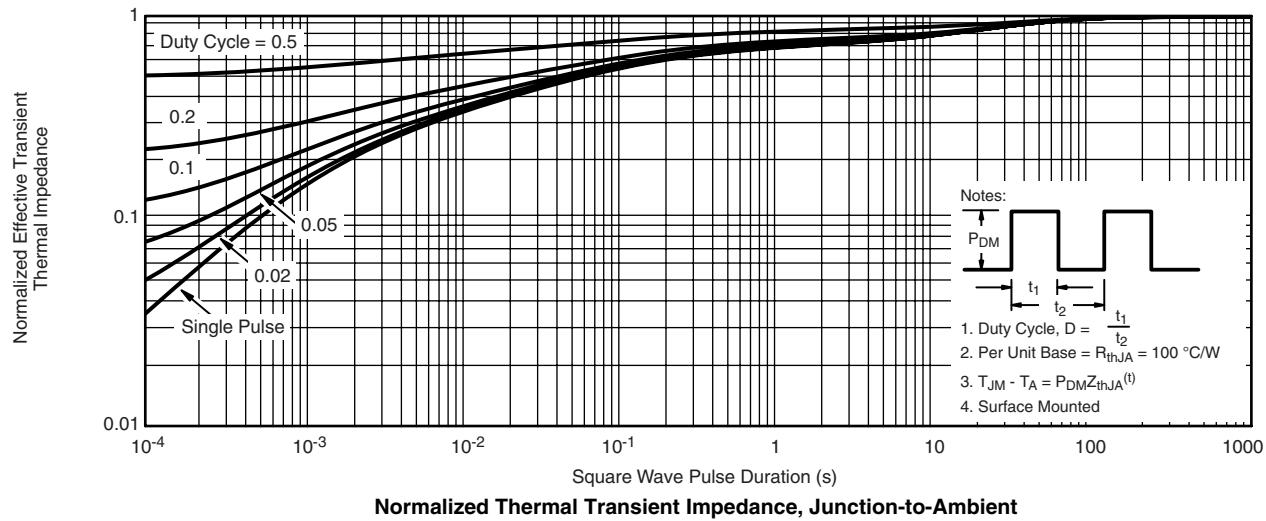
Threshold Voltage

\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient

**MOSFET TYPICAL CHARACTERISTICS**  $T_A = 25\text{ }^{\circ}\text{C}$ , unless otherwise noted

\* The power dissipation  $P_D$  is based on  $T_{J(\max)} = 150\text{ }^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**MOSFET TYPICAL CHARACTERISTICS**  $T_A = 25^\circ\text{C}$ , unless otherwise noted

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see [www.vishay.com/ppg?68860](http://www.vishay.com/ppg?68860).



### Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.